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Joachim Schulz graduated 1998 in experimental quantum optics at Hamburg University. For his PhD, he studied magnetic and linear dichroism in laser aligned and oriented rare earth atoms in the group of Bernd Sonntag at Hamburg University. From 2002, he setup a laser system at the soft x-ray beamtime I411 of the Swedish synchrotron source MAX II in Lund. Together with a team from Swedish universities in Uppsala and Lund and Oulu University (Finland), he performed photoelectron and Auger spectroscopy on laser excited metal atoms in the gas phase. In 2006 he was appointed Senior Lecturer in Physics at Oulu University. From 2007 Joachim Schulz was staff scientist at the Coherent X-ray Imaging Group of the Centre for Free-Electron Laser Science (CFEL) in Hamburg (Germany). Here he developed hardware for sample preparation for nano-crystallography and X-ray imaging of biological samples. Since 2011, he is Leader of the Sample Environment Group of the European XFEL GmbH, developing common sample environment methods for the European XFEL Facility.